

# L99MOD50XP

# Multi-output driver for automotive applications





# Features

- AEC-Q100 qualified
- Two half bridges for 6 A load (R<sub>DSon</sub> = 150 mΩ)
- Two half bridges for 3 A load (R<sub>DSon</sub> = 300 mΩ)
- Two half bridges for 0.75 A load (R<sub>DSon</sub> = 1600 mΩ)
- One high-side driver for 6 A load ( $R_{DSon} = 90 \text{ m}\Omega$ )
- Two configurable high-side drivers for up to 1.5A load ( $R_{DSon}$  = 500 m $\Omega$ ) or 0.4 A load ( $R_{DSon}$  = 1800 m $\Omega$ )
- Two high-side drivers for 0.5 A load  $(R_{DSon} = 1600 \text{ m}\Omega)$
- Programmable soft start function to drive loads with higher inrush currents as current limitation value
- Very low current consumption in standby mode (I<sub>S</sub> < 6  $\mu$ A typ; T<sub>j</sub> ≤ 85 °C; I<sub>CC</sub><5  $\mu$ A typ; T<sub>j</sub> ≤ 85 °C)
- Current monitor output for all high-side drivers

- Device contains temperature warning and protection
- Open-load detection for all outputs
- Over-current protection for all outputs
- PWM control of all outputs
- Charge pump output for reverse polarity protection
- ST standard serial peripheral interface (ST-SPI 3.0)

# Applications

L99MOD devices are recommended for those applications that need multiple motors control with additional loads in high-side configuration, such as bulbs/LEDs or requiring protected supply, like sensors or cameras.

# Description

The L99MOD50XP is a microcontroller-driven multifunctional actuator driver for automotive applications.

Up to five DC motors and five grounded resistive loads can be driven with six half bridges and five high-side drivers.

The integrated SPI controls all operating modes (forward, reverse, brake and high impedance).

Also all diagnostic information is available via SPI read.

#### Table 1. Device summary

Package	Order codes	Packing
PowerSSO-36	L99MOD50XPTR	Tape and reel

DS12615 Rev 4

1/42

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# 1 Block diagram and pin description

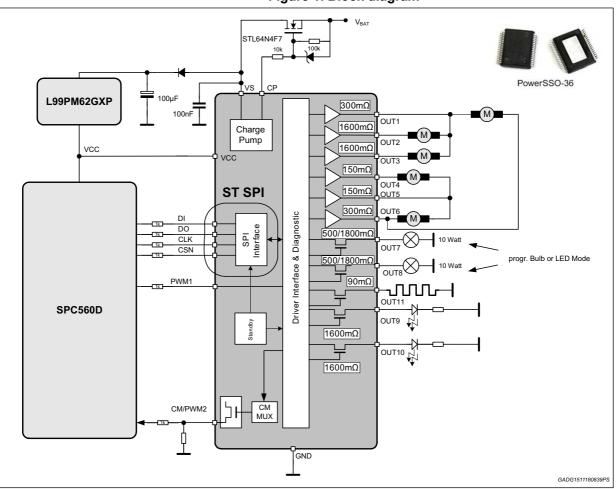


Figure 1. Block diagram



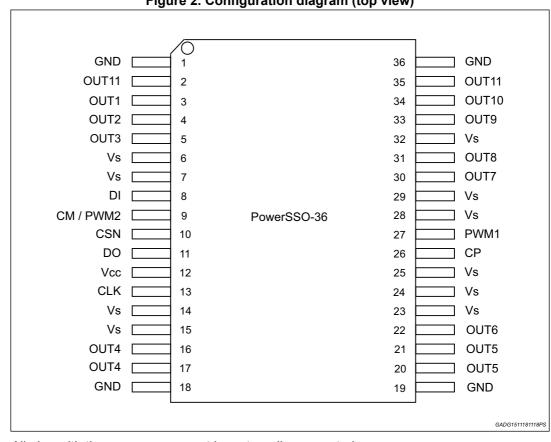


Figure 2. Configuration diagram (top view)

Note: All pins with the same name must be externally connected.



Pin	Symbol	Function
1, 18, 19, 36	GND	Ground: reference potential. <i>Important:</i> For the capability of driving the full current at the outputs all pins of GND must be externally connected!
2, 35	OUT11	High-side driver output 11. The output is built by a high-side switch and is intended for resistive loads, therefore the internal reverse diode from GND to the output is missing. For ESD reason a diode to GND is present, but the energy which can be dissipated is limited. The high-side driver is a power DMOS transistor with an internal parasitic reverse diode from the output to VS (bulk-drain-diode). The output is over-current protected. <i>Important:</i> for the capability of driving the full current at the outputs both pins of OUT11 must be externally connected!
3 4 5	OUT1, OUT2, OUT3	Halfbridge outputs 1,2,3. The output is built by a high-side and a low-side switch, which are internally connected. The output stage of both switches is a power DMOS transistor. Each driver has an internal parasitic reverse diode (bulk-drain-diode: high-side driver from output to VS, low-side driver from GND to output). This output is over-current protected.
6, 7, 14, 15, 23, 24, 25, 28, 29, 32	Vs	Power supply voltage (external reverse protection required). For this input a ceramic capacitor as close as possible to GND is recommended. <i>Important:</i> For the capability of driving the full current at the outputs all pins of VS must be externally connected! Pins 25 and 32 can be connected to VS to maintain compatibility with other L99MOD products; otherwise they should be left Not Connected
8	DI	Serial data input. The input requires CMOS logic levels and receives serial data from the microcontroller. The data is a 24 bit control word and the most significant bit (MSB, bit 23) is transferred first.
9	CM/ PWM2	Current monitor output/PWM2 input. Depending on the selected multiplexer bits of the control register this output sources an image of the instant current through the corresponding high-side driver with a ratio of 1/10.000 or 1/2000. This pin is bidirectional. The microcontroller can overdrive the current monitor signal to provide a second PWM input for the outputs OUT5, OUT8 and OUT10.
10	CSN	Chip Select Not input This input is low active and requires CMOS logic levels. The serial data transfer between L99MOD50XP and the microcontroller is enabled by pulling the input CSN to low level.
11	DO	Serial data output. The diagnosis data is available via the SPI and this tristate-output. The output will remain in tristate, if the chip is not selected by the input CSN (CSN = high)
12	VCC	Supply voltage. For this input a ceramic capacitor as close as possible to GND is recommended.
13	CLK	Serial clock input. This input controls the internal shift register of the SPI and requires CMOS logic levels.
16,17 20,21 22	OUT4, OUT5, OUT6	Half-bridge outputs 4,5,6: see OUT1 (pin 3). <i>Important:</i> For the capability of driving the full current at the outputs both pins of OUT4 (OUT5, respectively) must be externally connected!

#### Table 2. Pin definition and functions



Pin	Symbol	Function
26	СР	Charge pump output. This output is provided to drive the gate of an external n-channel power MOS used for reverse polarity protection (see <i>Figure 1</i> .).
27	PWM1	PWM1 input. This input signal can be used to control the drivers OUT1-4, OUT6-7, OUT9 and OUT11 by an external PWM signal.
30 31	OUT7, OUT8,	High-side driver outputs 7,8: see OUT9. By selection of one of the 2 power DMOS at same output is it possible to supply a bulb with low on-resistance or a LED with higher on-resistance in a different application.
33	OUT9	High-side driver output 9. The output is built by a high-side switch and is intended for resistive loads, hence the internal reverse diode from GND to the output is missing. For ESD reason a diode to GND is present but the energy which can be dissipated is limited. The high-side driver is a power DMOS transistor with an internal parasitic reverse diode from the output to VS (bulk-drain-diode). The output is over-current and open load protected.
34	OUT10	High-side driver output 10: see OUT9. <i>Important:</i> beside the bit10 in control register 1 this output can be switched on setting bit1 for electrocromic control mode with higher priority.

Table 2. Pin definition and functions	(continued)
	(continucu)



# 2 Electrical specifications

### 2.1 Absolute maximum ratings

Stressing the device above the rating listed in the "Absolute maximum ratings" table may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the Operating sections of this specification is not implied. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality document.

Symbol	Parameter	Value	Unit
) /-	DC supply voltage	-0.328	V
Vs	Single pulse t <sub>max</sub> < 400 ms	40	V
Vcc	Stabilized supply voltage, logic supply	-0.3 to 5.5	V
V <sub>DI</sub> , V <sub>DO,</sub> V <sub>CLK,</sub> V <sub>CSN,</sub> V <sub>PWM</sub>	Digital input / output voltage	-0.3 to V <sub>CC</sub> + 0.3	V
V <sub>CM</sub>	Current monitor output	-0.3 to V <sub>CC</sub> + 0.3	V
V <sub>CP</sub>	Charge pump output	-25 to V <sub>S</sub> + 11	V
V <sub>OUTn</sub>	Static output voltage (n= 1 to 11)	-0.3 to V <sub>S</sub> + 0.3	V
I <sub>OUT,2,3,9,10</sub>	Output current	±1.25	Α
I <sub>OUT1,6,7,8</sub>	Output current	±5	Α
I <sub>OUT4,5,11</sub>	Output current	±10	Α

Table	3.	Absolute	maximum	ratings
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# 2.2 ESD protection

#### Table 4. ESD protection

Parameter	Value	Unit
All pins	± 2 <sup>(1)</sup>	kV
Output pins: OUT1 - OUT6	± 4 <sup>(2)</sup>	kV

1. HBM according to MIL 883C, Method 3015.7 or EIA/JESD22-A114-A.

2. HBM with all unzapped pins grounded.



# 2.3 Thermal data

Symbol	Parameter	Value	Unit
Тj	Operating junction temperature	-40 to 150	°C

#### Table 5. Operating junction temperature

#### Table 6. Temperature warning and thermal shutdown

Symbol	Parameter		Min.	Тур.	Max.	Unit
T <sub>jTW ON</sub>	Temperature warning threshold junction temperature	Tj	130		150	°C
T <sub>jSD ON</sub>	Thermal shutdown threshold junction temperature	T <sub>j</sub> increasing			170	°C
T <sub>jSD OFF</sub>	Thermal shutdown threshold junction temperature	T <sub>j</sub> decreasing	150			°C
T <sub>jSD HYS</sub>	Thermal shutdown hysteresis			5		°K

### 2.4 Electrical characteristics

 $V_S$  = 8 to 16 V,  $V_{CC}$  = 4.5 to 5.3 V,  $T_j$  = - 40 to 150 °C, unless otherwise specified.

The voltages are referred to GND and currents are assumed positive, when the current flows into the pin.

ltem	Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
7.1	VS	Operating voltage range		7		28	V
7.2		V <sub>S</sub> DC supply current	V <sub>S</sub> = 16 V, V <sub>CC</sub> = 5.3 V active mode OUT1 - OUT11		7	20	mA
7.3	I <sub>S</sub>	<sub>S</sub> quiescent supply current O	$V_{S}$ = 16 V, $V_{CC}$ = 0 V standby mode OUT1 - OUT11 T <sub>test</sub> = -40°C, 25°C		4	12	μΑ
7.4 <sup>(1)</sup>			T <sub>test</sub> = 85°C		6	25	
7.5		V <sub>CC</sub> DC supply current	$V_{S}$ = 16 V, $V_{CC}$ = 5.3 V CSN = $V_{CC}$ , active mode OUT1 - OUT11		1	3	mA
7.6 <sup>(2)</sup>	I <sub>CC</sub>	V <sub>CC</sub> quiescent supply current	$V_{S} = 16 V,$ $V_{CC} = 5.3 V_{CSN} = V_{CC}$ standby mode OUT1 - OUT11 $T_{test} = -40^{\circ}C, 25^{\circ}C$		3	6	μA
7.7 <sup>(1)</sup>			T <sub>test</sub> = 85°C		5	10	

#### Table 7. Supply

1. This parameter is guaranteed by design.

2. CM/ PWM 2 =  $V_{CC}$  or 0 V.



Item	Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
8.1	V <sub>SUV on</sub>	V <sub>S</sub> UV-threshold voltage	V <sub>S</sub> increasing	5.6		7.2	V
8.2	V <sub>SUV off</sub>	V <sub>S</sub> UV-threshold voltage	V <sub>S</sub> decreasing	5.2		6.1	V
8.3	V <sub>SUV hyst</sub>	V <sub>S</sub> UV-hysteresis	V <sub>SUV ON</sub> - V <sub>SUV OFF</sub>		0.5		V
8.4	V <sub>SOV off</sub>	V <sub>S</sub> OV-threshold voltage	V <sub>S</sub> increasing	18		24.5	V
8.5	V <sub>SOV on</sub>	V <sub>S</sub> OV-threshold voltage	V <sub>S</sub> decreasing	17.5		23.5	V
8.6	V <sub>SOV hyst</sub>	V <sub>S</sub> OV-hysteresis	V <sub>SOV OFF</sub> - V <sub>SOV ON</sub>		1		V
8.7	V <sub>POR off</sub>	Power-on-reset threshold	V <sub>CC</sub> increasing			2.9	V
8.8	V <sub>POR on</sub>	Power-on-reset threshold	V <sub>CC</sub> decreasing	2.0			V
8.9	V <sub>POR hyst</sub>	Power-on-reset hysteresis	V <sub>POR OFF</sub> - V <sub>POR ON</sub>		0.11		V

 Table 8. Overvoltage and under voltage detection

Table 9. Current monitor output CM / PWM 2

Item	Symbol	Parameter	Test condition		Min.	Тур.	Мах	Unit
9.1	V <sub>CM</sub>	Functional voltage range			0		V <sub>CC</sub> - 1V	V
9.2	I <sub>CM,r</sub>	Current monitor output ratio: I <sub>CM</sub> / I <sub>OUT1,4,5,6,11 and 7,8</sub> (low on-resistance)	0 V <= V <sub>CM</sub> <= 4 V V <sub>CC</sub> =5 V			1 10.000		
9.3		I <sub>CM</sub> / I <sub>OUT2,3,9,10 and 7,8</sub> (high on-resistance)			1 2000			
9.4	I <sub>CM acc</sub>	Current monitor accuracy accl <sub>CMOUT1,4,5,6,11</sub> and 7, 8 (low on-res.)	V <sub>CM</sub> <= 3.8 V,	I <sub>Out,min</sub> = 500 mA I <sub>Out4,5,11max</sub> = 5.9 A I <sub>Out1,6 max</sub> = 2.9 A I <sub>Out7,8 max</sub> = 1.3 A	-8% - 2%FS	0	8% + 2%FS <sup>(</sup>	A
9.5		accl <sub>CMOUT2,3,9,10,</sub> and 7, 8 (high on-res.)		I <sub>Out,min</sub> = 100 mA I <sub>Out2,3 max</sub> = 0.6 A I <sub>Out9,10max</sub> = 0.4 A I <sub>Out8 max</sub> = 0.3 A	(1)		1)	

1. FS (full scale)= I<sub>OUTmax \*</sub> I<sub>CMr\_typ</sub>.

Item	Symbol	Parameter	Test condition	Min.	Тур.	Мах	Unit				
10.1		Charge pump output	V <sub>S</sub> = 8 V, I <sub>CP</sub> = -60 μA	V <sub>S</sub> +6		V <sub>S</sub> +13	V				
10.2	V <sub>CP</sub>		V <sub>S</sub> = 10 V, I <sub>CP</sub> = -80 μA	V <sub>S</sub> +8		V <sub>S</sub> +13	V				
10.3			V <sub>S</sub> >=12 V, I <sub>CP</sub> = -100 μA	V <sub>S</sub> +10		V <sub>S</sub> +13	V				
10.4	I <sub>CP</sub>	Charge pump output current	V <sub>CP</sub> = V <sub>S</sub> +10 V, V <sub>S</sub> =13.5 V	95	150	300	μA				



# 2.4.1 Outputs OUT1 - OUT11

Item	Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
11.1	<sup>r</sup> on out1,	On-resistance to supply or	V <sub>S</sub> = 13.5 V, T <sub>j</sub> = 25 °C, I <sub>OUT1,6</sub> = ± 1.5 A		300	400	mΩ
11.2	ron out6	GND	$V_{S} = 13.5 V,$ $T_{j} = 125 °C,$ $I_{OUT1,6} = \pm 1.5 A$		450	600	mΩ
11.3	<sup>r</sup> on out2.	On-resistance to supply or	$V_{S} = 13.5 V,$ $T_{j} = 25 °C,$ $I_{OUT2,3} = \pm 0.4 A$		1600	2200	mΩ
11.4	ron out3	GND	$V_{S} = 13.5 V,$ $T_{j} = 125 °C,$ $I_{OUT2,3} = \pm 0.4 A$		2500	3400	mΩ
11.5	<sup>r</sup> on out4.	On OUT4, On-resistance to supply or GND	$V_{S} = 13.5 V,$ $T_{j} = 25 °C,$ $I_{OUT4,5} = \pm 3.0 A$		150	200	mΩ
11.6	ron out5		$V_{S} = 13.5 V,$ $T_{j} = 125 °C,$ $I_{OUT4,5} = \pm 3.0 A$		225	300	mΩ
11.7	ron out9.	<sup>r</sup> ON OUT9, r <sub>ON OUT10</sub> On-resistance to supply	V <sub>S</sub> = 13.5 V, T <sub>j</sub> = 25 °C, I <sub>OUT9,10</sub> = -0.4 A		1600	2200	mΩ
11.8			V <sub>S</sub> = 13.5 V, T <sub>j</sub> = 125 °C, I <sub>OUT9,10</sub> = -0.4 A		2500	3400	mΩ
11.9	r	r <sub>ON OUT11</sub> On-resistance to supply	V <sub>S</sub> = 13.5 V, T <sub>j</sub> = 25 °C, I <sub>OUT11</sub> = -3.0 A		90	130	mΩ
11.10	'ON OUT11		V <sub>S</sub> = 13.5 V, T <sub>j</sub> = 125 °C, I <sub>OUT11</sub> = -3.0 A		130	180	mΩ

Table 11. On-resistance and switching times



ltem	Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
11.11		On-resistance to supply in	V <sub>S</sub> = 13.5 V, T <sub>j</sub> = 25 °C, I <sub>OUT7,8</sub> = - 0.8 A		500	700	mΩ
11.12	ronout7	low mode (control register 1 bits 12 to15: 0101)	$V_{\rm S}$ = 13.5 V, T <sub>j</sub> = 125 °C, I <sub>OUT7,8</sub> = - 0.8 A		700	950	mΩ
11.13	r <sub>ON OUT8</sub>	On-resistance to supply in high mode (control register 1 bits 12 to15: 1010)	V <sub>S</sub> = 13.5 V, T <sub>j</sub> = 25 °C, I <sub>OUT7,8</sub> = - 0.2 A		1800	2400	mΩ
11.14			$V_{S}$ = 13.5 V, T <sub>j</sub> = 125 °C, I <sub>OUT7,8</sub> = - 0.2 A		2500	3400	mΩ
11.15		Switched-off output current high-side drivers of OUT1-6,	V <sub>OUT</sub> = 0 V, standby mode	-5	-2		μA
11.16	I <sub>QLH</sub>		-10	-7		μA	
11.17	1.	Switched-off output current high-side drivers of OUT7-8	V <sub>OUT</sub> = 0 V, standby mode	-5	-2		μA
11.18	I <sub>QLH7,8</sub>		V <sub>OUT</sub> = 0 V, active mode	-15	-10		μA
11.19	1	Switched-off output current	V <sub>OUT</sub> = V <sub>S</sub> , standby mode		80	120	μA
11.20	I <sub>QLL</sub>	low-side drivers of OUT1-6	V <sub>OUT</sub> = 0 V, active mode	-10	-7		μA
11.21		Output delay time, high-side driver on $(OUT_X except OUT_{7,8})$		20	40	80	μs
11.22	t <sub>d ON H</sub>	Output delay time, high-side driver on (OUT <sub>7,8</sub> in high R <sub>DSon</sub> mode)	$V_{S} = 13.5 V,$ $V_{CC} = 5 V (1)(2)(3)$	15	35	60	μs
11.23		Output delay time, high-side driver on (OUT <sub>7,8</sub> in low R <sub>DSon</sub> mode)	-	10	35	80	μs
11.24		Output delay time, high-side driver off (OUT <sub>1, 4,</sub> 5, 6, 11)	V - 135V	60	150	200	μs
11.25	t <sub>d OFF H</sub>	Output delay time, high-side driver off (OUT <sub>2,3,7</sub> , high/low R <sub>DSon,8</sub> high/low R <sub>DSon,9,10</sub> )	$V_{\rm S}$ = 13.5 V, $V_{\rm CC}$ = 5 V <sup>(1)(2)(3)</sup>	40	70	100	μs

Table 11. On-resistance and switching times (continued)



Item	Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit				
11.26	t <sub>d ON L</sub>	Output delay time, low-side driver On	$V_{S}$ = 13.5 V, $V_{CC}$ = 5 V, corresponding high-side driver is not active <sup>(1)(2)(3)</sup>	15	30	70	μs				
11.27	t <sub>d OFF L 1-6</sub>	Output delay time, low-side driver OUT 1-6 off	V <sub>S</sub> =13.5 V, V <sub>CC</sub> =5 V <sup>(1)(2)(3)</sup>	40	150	300	μs				
11.28	t <sub>D HL</sub>	Cross current protection	$t_{cc ONLS_OFFHS} - t_{d OFFH}^{(4)}$	50	200	400	116				
11.29	t <sub>D LH</sub>	time	$t_{cc \text{ ONHS_OFFLS}} - t_{d \text{ OFFL}}^{(4)}$	50	200	400	μs				
11.30	dV <sub>OUT</sub> /dt <sub>on/</sub>	Slew rate of OUTx	$V_{\rm S}$ = 13.5 V, $V_{\rm CC}$ = 5 V <sup>(1)(2)(3)</sup>	0.1	0.2	0.6	V/µs				

 Table 11. On-resistance and switching times (continued)

1. Rload = 16  $\Omega$  at OUT1, 6 and 7,8 in low on-resistance mode.

2. Rload = 4  $\Omega$  at OUT4, 5 and 11.

3. Rload = 64  $\Omega$  at OUT2, 3, 9, 10 and 7, 8 in high On-resistance mode.

4.  $t_{\rm cc}$  is the switch-on delay time if complement in half bridge has to switch-off.

Item	Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
12.1	I <sub>OC1</sub>  ,  I <sub>OC6</sub>		N 40 5 M	3		5	А
12.2	I <sub>OC2</sub>  ,  I <sub>OC3</sub>	Over-current threshold to V	$ V_{a} = 5 \rangle$	0.75		1.25	А
12.3	I <sub>OC4</sub>  ,  I <sub>OC5</sub>			6		10	А
12.4	I <sub>OC9</sub>  ,  I <sub>OC10</sub>	Over-current threshold to	$V_{\rm S} = 13.5 \text{ V},$	0.5		1.0	А
12.5	I <sub>OC11</sub>	Supply	$V_{CC}$ = 5 V, source	6		10	А
12.6	I <sub>OC7</sub>  ,	Over-current threshold to supply in low on-resistance mode	$V_{S}$ = 13.5 V, $V_{CC}$ = 5 V, source, control register 1 bits 12 to 15: 0101	1.5		2.5	A
12.7	I <sub>OC8</sub>	Over-current threshold to supply in high on-resistance mode	$V_{S}$ = 13.5 V, $V_{CC}$ = 5 V, source, control register 1 bits 12 to 15: 1010	0.35		0.65	A
12.8	t <sub>FOC</sub>	Filter time of over-current signal	Duration of over-current condition to set the status bit	10	55	100	μs
12.9	f <sub>rec0</sub>	Recovery frequency for OC recovery duty cycle bit= 0		1		4	kHz
12.10	f <sub>rec1</sub>	Recovery frequency for OC recovery duty cycle bit= 1		2		6	kHz

#### Table 12. Current monitoring



ltem	Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit					
12.11	II <sub>OLD1</sub> I, II <sub>OLD6</sub> I		V <sub>S</sub> = 13.5 V,	10	30	80	mA					
12.12	ll <sub>OLD2</sub> I, Il <sub>OLD3</sub> I	Under-current threshold to supply or GND	$V_{\rm S}$ = 13.5 V, $V_{\rm CC}$ = 5 V, sink and source	10	20	30	mA					
12.13	ll <sub>OLD4</sub> I, Il <sub>OLD5</sub> I			60	150	300	mA					
12.14	II <sub>OLD9</sub> I, II <sub>OLD10</sub> I	Under-current threshold to supply		5	10	15	mA					
12.15	II <sub>OLD11</sub> I			30	150	300	mA					
12.16	ll <sub>old7</sub> l,	Under-current threshold to supply in low on-resistance mode	$V_S$ = 13.5 V, $V_{CC}$ = 5 V, source	15	40	60	mA					
12.17	II <sub>OLD8</sub> I Under-current threshold to supply in high on-resistance mode	5	10	15	mA							
12.18	t <sub>FOL</sub>	Filter time of under-current	Duration of under-current condition to set the status bit	0.5		3	ms					

 Table 12. Current monitoring (continued)

## 2.5 SPI - Electrical characteristics

 $V_S$  = 8 to 16 V,  $V_{CC}$  = 4.5 to 5.5 V,  $T_j$  = - 40 to 150°C, unless otherwise specified. The voltages are referred to GND and currents are assumed positive, when the current flows into the pin.

ltem	Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
14.1	t <sub>set</sub>	Delay time	Switching from standby to active mode. Time until output drivers are enabled after CSN going to high and set bit 0=1 of control register 0.		256	300	μs

Table 14	Innuts <sup>.</sup>	CSN	CIK	PWM1/2 and DI	
	inputs.	0011,	OLN,		

ltem	Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
15.1	V <sub>inL</sub>	Input low level	V <sub>CC</sub> = 5 V			0.3* Vcc	V
15.2	V <sub>inH</sub>	Input high level	V <sub>CC</sub> = 5 V	0.7* Vcc			V
15.3	V <sub>in Hyst</sub>	Input hysteresis V <sub>CC</sub> = 5 V		500			mV
15.4	R <sub>CSN in</sub>	CSN pull up resistor	V <sub>CC</sub> = 5 V 0 V <v<sub>CSN&lt;0.7 V<sub>CC</sub></v<sub>	30	120	250	kΩ



Item	Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
15.5	R <sub>CLK in</sub>	CLK pull down resistor	V <sub>CC</sub> = 5 V V <sub>CLK</sub> = 1.5 V	30	60	150	kΩ
15.6	R <sub>DI in</sub>	DI pull down resistor	V <sub>CC</sub> = 5 V V <sub>DI</sub> = 1.5 V	30	60	150	kΩ
15.7	R <sub>PWM1 in</sub>	PWM1 pull down resistor	V <sub>CC</sub> = 5 V V <sub>PWM1</sub> = 1.5 V	30	60	150	kΩ
15.8	C <sub>in</sub> <sup>(1)</sup>	Input capacitance at input CSN, CLK, DI and PWM1/2	0 V < V <sub>CC</sub> < 5.3 V			10	pF

#### Table 14. Inputs: CSN, CLK, PWM1/2 and DI (continued)

1. Value of input capacity is not measured in production test. Parameter guaranteed by design.

ltem	Symbol	Parameter <sup>(1)</sup> Test condition		Min.	Тур.	Max.	Unit
16.1	t <sub>CLK</sub>	Clock period	V <sub>CC</sub> = 5 V		1000		ns
16.2	t <sub>CLKH</sub>	Clock high time	V <sub>CC</sub> = 5 V	115			ns
16.3	t <sub>CLKL</sub>	Clock low time	V <sub>CC</sub> = 5 V	115			ns
16.4	t <sub>set CSN</sub>	CSN setup time, CSN low before rising edge of CLK	V <sub>CC</sub> = 5 V	400			ns
16.5	t <sub>set CLK</sub>	CLK setup time, CLK high before rising edge of CSN	V <sub>CC</sub> = 5 V	400			ns
16.6	t <sub>set DI</sub>	DI setup time	V <sub>CC</sub> = 5 V	200			ns
16.7	t <sub>hold DI</sub>	DI hold time	V <sub>CC</sub> = 5 V	200			ns
16.8	t <sub>r in</sub>	Rise time of input signal DI, CLK, CSN	V <sub>CC</sub> = 5 V			100	ns
16.9	t <sub>f in</sub>	Fall time of input signal DI, CLK, CSN	V <sub>CC</sub> = 5 V			100	ns

#### Table 15 SDI timing

DI timing parameters tested in production by a passed / failed test: Tj = -40°C / +25°C: SPI communication @ 2 MHz. Tj = +125°C: SPI communication @ 1.25 MHz.

#### Table 16. DO

ltem	Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
17.1	V <sub>DOL</sub>	Output low level	I <sub>DO</sub> = -5 mA			0.2V <sub>CC</sub>	V
17.2	V <sub>DOH</sub>	Output high level	I <sub>DO</sub> = 5 mA	0.8 V <sub>CC</sub>			V
17.3	I <sub>DOLK</sub>	Tristate leakage current	$V_{CSN} = V_{CC},$ 0 V < V <sub>DO</sub> < V <sub>CC</sub>	-10		10	μA
17.4	C <sub>DO</sub> <sup>(1)</sup>	Tristate input capacitance	$V_{\rm CSN} = V_{\rm CC},$ 0 V < V_{\rm CC} < 5.3 V			10	pF

1. Value of input capacity is not measured in production test. Parameter guaranteed by design.



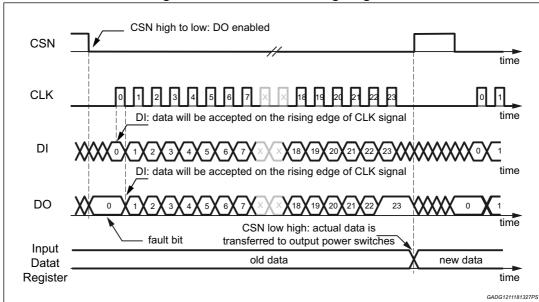
ltem	Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
18.1	t <sub>r DO</sub>	DO rise time	C <sub>DO</sub> = 100 pF		80	140	ns
18.2	t <sub>f DO</sub>	DO fall time	C <sub>DO</sub> = 100 pF		50	100	ns
18.3	t <sub>en DO tri L</sub>	DO enable time from tristate to low level	$C_{DO}$ = 100 pF, I <sub>load</sub> = 1 mA pull- up load to V <sub>CC</sub>		100	250	ns
18.4	t <sub>dis DO L tri</sub>	DO disable time from low level to tristate	$C_{DO}$ = 100 pF, I <sub>load</sub> = 4 mA pull- up load to V <sub>CC</sub>		380	450	ns
18.5	t <sub>en DO tri H</sub>	DO enable time from tristate to high level	$C_{DO}$ =100 pF, $I_{load}$ = -1 mA pull- down load to GND		100	250	ns
18.6	t <sub>dis DO H tri</sub>	DO disable time from high level to tristate	C <sub>DO</sub> = 100 pF, I <sub>load</sub> = -4 mA pull-down load to GND		380	450	ns
18.7	t <sub>d DO</sub>	DO delay time	$V_{DO} < 0.3 V_{CC},$ $V_{DO} > 0.7 V_{CC},$ $C_{DO} = 100 \text{ pF}$		50	250	ns

Table 17. DO timing

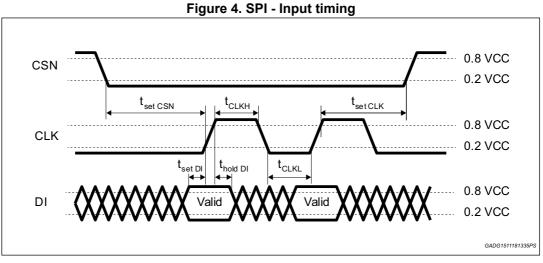
Table 18. CSN timing

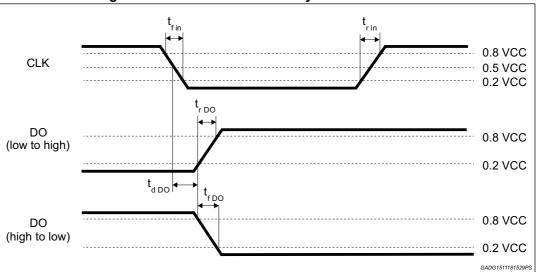
ltem	Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
19.1	t <sub>CSN_HI,stb</sub>	Minimum CSN HI time, switching from standby mode	Transfer of SPI-command to input register		20	50	μs
19.2	t <sub>CSN_HI,min</sub>	Minimum CSN HI time, active mode	Transfer of SPI-command to input register		2	4	μs

Figure 3. SPI - Transfer timing diagram













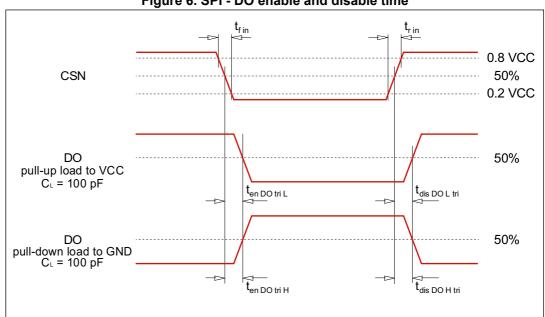
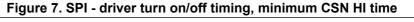
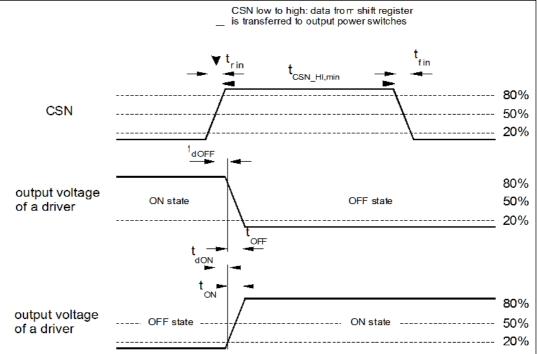


Figure 6. SPI - DO enable and disable time







# **3** Application information

## 3.1 Dual power supply: V<sub>S</sub> and V<sub>CC</sub>

The power supply voltage V<sub>S</sub> supplies the half bridges and the high-side drivers. An internal charge-pump is used to drive the high-side switches. The logic supply voltage V<sub>CC</sub> is used for the logic part and the SPI of the device.

Due to the independent logic supply voltage the control and status information is not lost, if there are temporary spikes or glitches on the power supply voltage.

### 3.2 Wake up and active mode / standby mode

After power up of VS and Vcc the device operates in standby-mode. Pulling the signal CSN to low level wakes the device up and the analog part is activated (active mode).

After at least 10µs, the first SPI communication is valid and bit 0 of the Control Register 0 can be used to set the EN-mode. If bit 0 is not set to 1, the device doesn't remain in the active mode. After at least 256 µs all latched data are cleared and the inputs and outputs are switched to high impedance. In standby mode the current at  $V_S (V_{CC})$  is less than 6 µA (5 µA) for CSN = high (DO in tristate).

### 3.3 Charge pump

In standby mode the charge-pump is turned off. After enabling the device by SPI command (bit0=1 Control Register 0) the oscillator starts and the voltage begins to increase. The output drivers are enabled after at least 256  $\mu$ s after CSN went to high.

# 3.4 Diagnostic functions

All diagnostic functions (over/under-current, power supply over-/undervoltage, temperature warning and thermal shutdown) are internally filtered. The condition has to be valid for at least 32  $\mu$ s (open load: 1 ms) before the corresponding status bit in the status registers is set.

The filters are used to improve the noise immunity of the device. The under-current and temperature warning functions are intended for information purpose and don't change the state of the output drivers. On the contrary, the over-current condition disables the corresponding driver and thermal shutdown disables all drivers. Without setting the over-current recovery bits in the input data register, the microcontroller has to clear the over-current status bits to reactivate the corresponding drivers.

# 3.5 Overvoltage and undervoltage detection at V<sub>S</sub>

If the power supply voltage VS rises above the overvoltage threshold V<sub>SOV OFF</sub> (typical 21 V), the outputs OUT1 to OUT11 are switched to high impedance state to protect the load. When the voltage VS drops below the undervoltage threshold V<sub>SUV OFF</sub> (UV-switch-OFF voltage), the output stages are switched to high impedance to avoid the operation of the power devices without sufficient gate driving voltage (increased power dissipation). If the



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supply voltage V<sub>S</sub> recovers (control register 3: bit 4=0) to normal operating voltage then the outputs stages return to the programmed state. If the undervoltage/overvoltage recovery disable bit is set (control register 3: bit 4=1), the automatic turn-on of the drivers is deactivated.

The microcontroller needs to clear the status bits to reactivate the drivers. It is recommended to set bit1 control register 3 to avoid a possible high current oscillation in case of a shorted output to GND and low battery voltage.

### 3.6 Overvoltage and undervoltage detection at V<sub>CC</sub>

In case of power-on (VCC increases from undervoltage to  $V_{POR OFF} = 2.9 \text{ V}$ ) the circuit is initialized by an internally generated power-on-reset (POR). If the voltage VCC decreases below the minimum threshold ( $V_{POR ON} = 2.0 \text{ V}$ ), the outputs are switched to tristate (high impedance) and the status registers are cleared.

### 3.7 Temperature warning and thermal shutdown

If the junction temperature rises above T<sub>j TW</sub>, a temperature warning flag is set after at least 32 µs and it can be read via the SPI. If the junction temperature increases above the second threshold T<sub>j SD</sub>, the thermal shutdown bit is set and the power DMOS transistors of all output stages are switched off to protect the device after at least 32 µs.

The temperature warning and thermal shutdown flags are latched and the bits must be cleared by the microcontroller. This is possible only if the temperature has decreased below trigger temperature. If the thermal shutdown bit has been cleared the output stages are reactivated.

### 3.8 Inductive loads

Each half bridge is built by internally connected high-side and low-side power DMOS transistors. Due to the built-in reverse diodes of the output transistors, inductive loads can be driven at the outputs OUT1 to OUT6 without external free-wheeling diodes. The high-side drivers OUT7 to OUT11 are intended to drive resistive loads. Therefore only a limited energy (E<1 mJ) can be dissipated by the internal ESD-diodes in freewheeling condition. For inductive loads (L>100  $\mu$ H) an external free-wheeling diode connected between GND and the corresponding output is required.

### 3.9 Open load detection

The open load detection monitors the load current in each activated output stage. If the load current is below the open load detection threshold for at least 1 ms ( $t_{dOL}$ ) the corresponding open load bit is set in the status register. Due to mechanical/electrical inertia of typical loads a short activation of the outputs (e.g. 3 ms) can be used to test the open load status without changing the mechanical/electrical state of the loads.

### 3.10 Over-load detection

In case of an over-current condition a flag is set in the status register in the same way as during open load detection. If the over-current signal is valid for at least  $t_{ISC}(typ) = 55 \ \mu s$ , the over-current flag is set and the corresponding driver is switched off to reduce the power dissipation and to protect the integrated circuit. If the over-current recovery bit of the output is zero, the microcontroller has to clear the status bits to reactivate the corresponding driver.

### 3.11 Current monitor

The current monitor output sources a current image at the current monitor output which has two fixed ratios of the instantaneous current of the selected high-side driver. Outputs with a resistance of 500 m $\Omega$  and higher have a ratio of 1/2000 and those with a lower resistance of 1/10000. The signal at output CM is blanked after switching on the driver until correct settlement of the circuitry (at least for 64 µs). The bits 0 to 3 of the control register 3 define which of the outputs are multiplexed to the current monitor output CM/PWM2. The current monitor output allows a more precise analysis of the actual state of the load rather than the detection of an open- or overload condition. For example it can be used to detect the motor state (starting, free-running, stalled). Moreover, it is possible to control the power of the defroster more precisely by measuring the load current. The current monitor output is bidirectional (PWM inputs).

### 3.12 PWM inputs

Each driver has a corresponding PWM enable bit, which can be programmed by the SPI interface. If the PWM enable bit is set in control registers 2 or 3, the output is controlled by the logically AND-combination of the PWM signal and the output control bit in Control Registers 0 and 1. The outputs OUT1-4, 6, 7, 9, OUT11 are controlled by the PWM1 input and the outputs OUT5, 8 and OUT10 are controlled by the bidirectional input CM/PMW2. For example, the two PWM inputs can be used to dim two lamps independently by external PWM signals. In case of switching off a high/low side switch in PWM mode a minimum off time of appr. (256  $\mu$ s – td<sub>on</sub> td<sub>off</sub>) is predefined by the state machine, to avoid switching on the high/low side again during the negative slope. For a PWM frequency of 100Hz this means the maximum duty cycle is about 98%. Larger duty cycles can be realized by applying pulse skipping.

### 3.13 Cross-current protection

The six half bridges of the device are cross-current protected by an internal delay time. If one driver (LS or HS) is turned off, the activation of the other driver of the same half bridge is automatically delayed by the cross-current protection time. After the cross-current protection time is expired the slew-rate limited switch-off phase of the driver is changed to a fast turn-off phase and the opposite driver is turned-on with slew-rate limitation. Due to this behavior it is always guaranteed that the previously activated driver is completely turned off before the opposite driver starts to conduct.



# 3.14 Programmable soft-start function to drive loads with higher inrush current

Loads with start-up currents higher than the over-current limits (e.g. inrush current of lamps, start current of motors and cold resistance of heaters) can be driven by using the programmable softstart function (i.e. overcurrent recovery mode). Each driver has a corresponding over-current recovery bit. If this bit is set, the device automatically switches the outputs on again after a programmable recovery time. The duty cycle in over-current condition can be programmed by the SPI interface to about 12% or 25%. The PWM modulated current provides sufficient average current to power up the load (e.g. heat up the bulb) until the load reaches operating condition. The PWM frequency settles at 1.7 kHz and 3 kHz. The device itself cannot distinguish between a real overload and a non linear load like a light bulb. A real overload condition can only be qualified by time. For over-load detection the microcontroller can switch on the light bulbs by setting the over-current recovery bit for the first e.g. 50 ms. After clearing the recovery bit the output is automatically switched off, if the overload condition remains. This over-load detection procedure has to be followed in order make it possible to switch on the low-side driver of a bridge output, if the associated high-side driver has been used in recovery mode before.

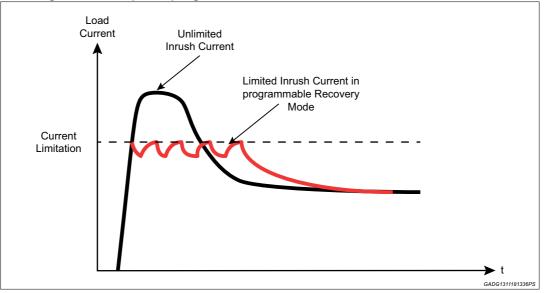


Figure 8. Example of programmable soft-start function for inductive loads



# 4 Functional description of the SPI

### 4.1 General description

Standard ST-SPI Interface Version 3.0.

The SPI communication is based on a Serial Peripheral Interface structure using CSN (Chip Select Not), DI (Serial Data In), DO (Serial Data Out/Error) and CLK (Serial Clock) signal lines.

### 4.1.1 Chip Select Not (CSN)

The input pin is used to select the serial interface of this device. When CSN is high, the output pin (DO) is in high impedance state. A low signal wakes up the device and a serial communication can be started. The state when CSN is going low until the rising edge of CSN is called a communication frame.

Note: The device includes a test mode. This mode is activated by a dedicated sequence which includes a high voltage at the CSN pin. The CSN pin must be kept at nominal voltage levels in order to avoid accidental activation of the test mode.

### 4.1.2 Serial Data In (DI)

The input pin is used to transfer data serially into the device. The data applied to the DI is sampled at the rising edge of the CLK signal.

### 4.1.3 Serial Clock (CLK)

This input signal provides the timing of the serial interface. The Data Input (DI) is latched at the rising edge of Serial Clock CLK. The SPI can be driven by a micro controller with its SPI peripheral running in following mode: CPOL = 0 and CPHA = 0. Data on Serial Data Out (DO) is shifted out at the falling edge of the serial clock (CLK). The serial clock CLK must be active only during a frame (CSN low). Any other switching of CLK close to any CSN edge could generate set up/hold violations in the SPI logic of the device.

The clock monitor counts the number of clock pulses during a communication frame (while CSN is low). If the number of CLK pulses does not correspond to the frame width indicated in the <SPI-frame-ID> (ROM address 03H) the frame is ignored and the *<frame error>* bit in the *<Global Status Byte>* is set.

Note: Due to this safety functionality, daisy chaining the SPI is not possible. Instead, a parallel operation of the SPI bus by controlling the CSN signal of the connected ICs is recommended.

### 4.1.4 Serial Data Out (DO)

The data output driver is activated by a logical low level at the CSN input and goes from high impedance to a low or high level depending on the global status bit 7 (Global Error Flag). The first rising edge of the CLK input after a high to low transition of the CSN pin transfers the content of the selected status register into the data out shift register. Each subsequent falling edge of the CLK shifts the next bit out.



#### 4.1.5 SPI communication flow

At the beginning of each communication the master can read the contents of the *<SPI-frame-ID>* register (ROM address 03H) of the slave device. This 8-bit register indicates the SPI frame length (24 bit) and the availability of additional features.

Each communication frame consists of a command byte which is followed by 2 data bytes.

The data returned on DO within the same frame always starts with the *<Global Status>* Byte. It provides general status information about the device. It is followed by 2 data bytes (i. e. *'In-frame-response'*).

For Write cycles the *<Global Status>* Byte is followed by the previous content of the addressed register.

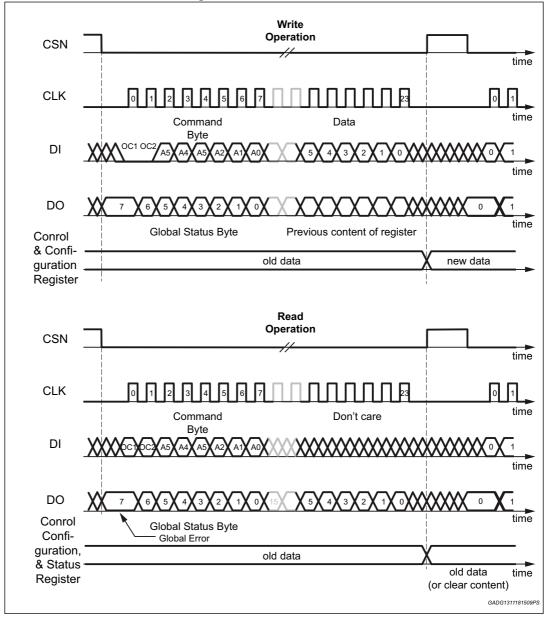


Figure 9. Write and read SPI



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											••••													
	Command byte					Data byte																		
Bit	23	22	21	29	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Name	OC 1	OC0	A5	A4	A3	A2	A1	A0	D7	D6	D5	D4	D3	D2	D1	D0	D7	D6	D5	D4	D3	D2	D1	D0

#### Table 19. SPI frame

Ocx: Operation code

Ax: Address

Dx: Data Bit

### 4.2 Command byte

Each communication frame starts with a command byte. It consists of an operating code which specifies the type of operation (*<Read>, <Write>, <Read and Clear>, <Read Device Information>*) and a 6 bit address. If less than 6 address bits are required, the remaining bits are unused but are reserved.

#### 4.2.1 Operation code definition

#### Table 20. Operation code definition

OC1	OC0	Meaning
0	0	<write mode=""></write>
0	1	<read mode=""></read>
1	0	<read and="" clear="" mode=""></read>
1	1	<read device="" information=""></read>

The <Write Mode> and <Read Mode> operations allow access to the RAM of the device.

*A* <*Read and Clear Mode>* operation is used to read a status register and subsequently clear its content.

*The <Read Device Information>* allows access to the ROM area which contains device related information such as <ID-Header>, <Product Code>, <Silicon Version and Category> and *<SPI-frame-ID>*.

### 4.3 Global status byte

#### Table 21. Global status byte

Bit	7	6	5	4	3	2	1	0
Name	GL_ER	CO_ER	C_RESET	TSD	ΤW	UOV_OC	OL	NR
Reset	0	0	1	0	0	0	0	0



Description:

- GL\_ER: Global Error Flag. Failures of Bits 0-6 are always linked to the Global Error Flag. This flag is generated by an OR combination of all failure events of the device. It is reflected via the DO pin while CSN is held low and no clock signal is available. The flag remains as long as CSN is low. This operation does not cause the Communication Error bit in the <Global Status> to be set. The signal TW bit3 and OL bit1can be masked.
- CO\_ER: Communication Error. If the number of clock pulses within the previous frame is not 24 the frame is ignored and this bit is set.
- C\_RESET: Chip RESET. If a stuck at '1' on input DI during any SPI frame occurs, or if a Power On Reset (VCC monitor) occurs. C\_RESET resets ('1') with any SPI command. When C\_RESET is active ('0'), the Gate drivers are switched off (resistive path to source).

After a startup of the circuit the C\_RESET is active because of the POR pulse and the Gate drivers are switched off. The Gate drivers can only be activated after the C\_RESET has been reset with a SPI command.

- TSD: Thermal shutdown due to an internal sensor. All the gate drivers and the charge pump are switched off (resistive path to source). The TSD bit has to be cleared through a software reset to reactivate the gate drivers and the charge pump.
- TW: Thermal Warning. This bit is maskable by configuration register.
- UOV\_OC: Logical OR among the filtered under-/over-voltage signals and over-current signals.
- OL: Open Load. Logical OR among the filtered under-current signals. This bit is maskable by configuration register.
- NR: Not Ready. After switching the device from standby mode to active mode an internal timer is started to allow charge-pump to settle before the outputs can be activated. This bit is cleared automatically after start up time has finished.

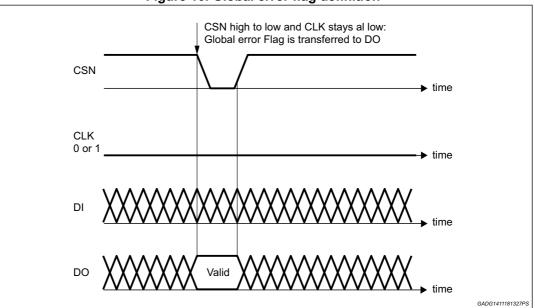


Figure 10. Global error flag definition



# 4.4 Address mapping

Address	Name	Access	Content
00h	Control register 0	Read/write	Enable of device and bridge control
01h	Control register 1	Read/write	High/low-side control and Electrocrome block set up
02h	Control register 2	Read/write	Bridge recovery mode and PWM set up and Electrocrome block set up
03h	Control register 3	Read/write	High-side recovery mode and PWM set up and current monitor selection
10h	Status register 0	Read only	Bridge over-current diagnosis
11h	Status register 1	Read only	Bridge open load (under-current) diagnosis
12h	Status register 2	Read only	Open load (under-current) diagnosis, VS and electrocrome diagnosis
3Fh	Configuration register	Read/write	Mask of bits in global status register and for global error bit

#### Table 22. RAM memory map

#### Table 23. ROM memory map

Address	Name Access		Content
00h	ID header	Read only	4300h (ASSP ST_SPI)
01h	Version	Read only	0300h
02h	Product code 1	Read only	4300h (67 ST_SPI)
03h	Product code 2	Read only	4800h (H ST_SPI)
3Eh	SPI-frame ID	Read only	0200h SPI-Frame-ID register (ST_SPI)



# 5 SPI - control and status registers

### 5.1 Control register 0

#### Table 24. Control register 0 (read/write)

Bit	Name	Comment			
15	OUT1 – HS on/off				
14	OUT1 – LS on/off				
13	OUT2 – HS on/off				
12	OUT2 – LS on/off				
11	OUT3 – HS on/off	If a bit is set the selected output driver is switched on. If the corresponding PWM			
10	OUT3 – LS on/off	enable bit is set the driver is only activated if PWM1 (PWM2) input signal is high. The outputs of OUT1-OUT6 are half bridges. If the bits of HS- and LS-driver of the same			
9	OUT4 – HS on/off	half bridge are set, the internal logic prevents that both drivers of this output stage car			
8	OUT4 – LS on/off	be switched on simultaneously in order to avoid a high internal current from Vs to GND.			
7	OUT5 – HS on/off				
6	OUT5 – LS on/off				
5	OUT6 – HS on/off				
4	OUT6 – LS on/off				
3	0				
2	0	Reserved (has to be set to '0')			
1	0				
0	Enable bit	If enable bit is set the device will be switched in active mode. If enable bit is cleared, the device enters standby mode and all bits are cleared.			

# 5.2 Control register 1

#### Table 25. Control register 1 (read/write)

Bit	Name		Comment					
15	15 OUT7 – HS1	OUT7/8						
	on/off							
14	OUT7 – HS2		HS1	HS2	Mode			
14	on/off		1	1	Off			
13	12 OUT8 – HS1		1	0	Low on-resistance			
on/off		0	1	High on-resistance				
12 OUT8 – HS	OUT8 – HS2		0	0	Off			
12	on/off							



Bit	Name	Comment				
11	OUT9 – HS on/off	If a bit is set, the selected output driver is switched on. If the corresponding PWM enable				
10	OUT10 – HS on/off	bit is set the driver is only activated if PWM1 (PWM2) input signal is high. The outputs of OUT1-OUT6 are half bridges. If the bits of HS- and LS-driver of the same half bridge are set, the internal logic prevents that both drivers of this output stage can be switched on				
9	OUT11 – HS on/off	simultaneously in order to avoid a high internal current from VS to GND.				
8-1	Reserved	Reserved (has to be set to '0')				
0	0	Reserved (has to be set to '0')				

#### Table 25. Control register 1 (read/write) (continued)

# 5.3 Control register 2

Bit	Name	Comment	
15	OUT1 – OCR enable	In some of an over everythe every everytheter with (Status Deviator O) is	
14	OUT2 – OCR enable	In case of an over-current event the over-current status bit (Status Register 0) is set and the output is switched off. If the Over-current Recovery Enable bit (OCR) is	
13	OUT3 – OCR enable	set, the output will be automatically reactivated after a delay time resulting in a PWM modulated current with a programmable duty cycle (bit 5 of control register	
12	OUT4 – OCR enable	3).	
11	OUT5 – OCR enable	Depending on occurrence of over-current event and internal clock phase it is possible that one recovery cycle is executed even if this bit is set to zero.	
10	OUT6 – OCR enable		
9	0	Reserved (has to be set to '0')	
8	0	Reserved (has to be set to '0')	
7	OUT1 PWM1 enable		
6	OUT2 PWM1 enable		
5	OUT3 PWM1 enable	If the PWM1/2 Enable bit is set and the output is enabled (control register 0 or 1)	
4	OUT4 PWM1 enable	the output is switched on if PWM1/2 input is high and switched off if PWM1/2 input is low. OUT5, 8 and OUT10 are controlled by PWM2 input, all other outputs are	
3	OUT5 PWM2 enable	controlled by PWM1 input.	
2	OUT6 PWM1 enable	1	
1	Reserved		
0	Reserved	Reserved	

#### Table 26. Control register 2 (read/write)



# 5.4 Control register 3

Table 27.	Control	reaister	3	(read/write)
	••••••		-	(

Bit	Name				Co	omment		
15	OUT7-OCR enable	In case of an over-current event the over-current status bit (Status register 1)						
14	OUT8-OCR enable	is set and the output is switched off. If the Over-current Recovery Enable bit (OCR) is set the output will be automatically reactivated after a delay time					t	
13	OUT9-OCR enable	resulting	g in a PW	/M modula	ated curre	nt with a p	rogrammable duty cycle (bit 5	
12	OUT10-OCR enable						ent event and the internal cloo executed even if this bit is set	
11	OUT11-OCR enable	zero.	•					
10	OUT7 PWM1 enable							
9	OUT8 PWM2 enable						is enabled (control register 0	or
8	OUT9 PWM1 enable						high and switched off if controlled by PWM2 input al	
7	OUT10 PWM2 enable				d by PWN		· · · · · · · · · · · · · · · · · · ·	
6	OUT11 PWM1 enable							
5	OCR frequency 0: 1.7 kHz 1: 3 kHz	This bit defines in combination with the over-current recovery bit (Input Register 1) the over-current recovery frequency of an activated driver.						
4	OV/UVR disable	If this bit is set the microcontroller has to clear the status register after undervoltage/overvoltage event to enable the outputs.						
3	CM select bit 3		selected output (	l high-side see table	e output C below).	)UTn will b	0 the current image of the e multiplexed to the CM/PWM rrent monitor. Current image of	12
			0	0	0	0	OUT1	
		1	0	0	0	1	OUT2	
			0	0	1	0	OUT3	
2	CM select bit 2		0	0	1	1	OUT4	
			0	1	0	0	OUT5	
		1	0	1	0	1	OUT6	
	<b>.</b>		0	1	1	0	OUT7	
1	CM select bit 1		0	1	1	1	OUT8	
			1	0	0	0	OUT9	
		1	1	0	0	1	OUT10	
			1	0	1	0	OUT11	
0	CM select bit 0		L					

# 5.5 Status register 0

Bit	Name	Comment				
15	OUT1 – HS OC					
14	OUT1 – LS OC					
13	OUT2 – HS OC					
12	OUT2 – LS OC					
11	OUT3 – HS OC	In case of an over-current event the corresponding status bit is set and the output				
10	OUT3 – LS OC	<ul> <li>driver is disabled. If the over-current Recovery Enable bit is set the output will be automatically reactivated after a delay time resulting in a PWM modulated current with a programmable duty cycle.</li> <li>If the over-current recovery bit is not set, the micro controller has to clear the over-current bit to reactivate the output driver.</li> </ul>				
9	OUT4 – HS OC					
8	OUT4 – LS OC					
7	OUT5 – HS OC					
6	OUT5 – LS OC					
5	OUT6 – HS OC					
4	OUT6 – LS OC					
3	0					
2	0					
1	0	Reserved				
0	0					

#### Table 28. Status register 0 (read)

# 5.6 Status register 1

Table	29.	Status	register	1	(read)
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Bit	Name	Comment
15	OUT1 – HS UC	Maskable by the
14	OUT1 – LS UC	configuration register
13	OUT2 – HS UC	
12	OUT2 – LS UC	
11	OUT3 – HS UC	
10	OUT3 – LS UC	The open load detection monitors the load current in each activated output stage. If the
9	OUT4 – HS UC	load current is below the under-current detection threshold for at least 1 ms ( $t_{dOL}$ ), the
8	OUT4 – LS UC	corresponding under-current bit UC is set. Due to mechanical/electrical inertia of typical loads a short activation of the outputs (e.g. 3ms) can be used to test the open
7	OUT5 – HS UC	load status without changing the mechanical/electrical state of the loads.
6	OUT5 – LS UC	
5	OUT6 – HS UC	
4	OUT6 – LS UC	



Bit	Name	Comment				
3	0					
2	0	Reserved				
1	0	Reserved				
0	0					

#### Table 29. Status register 1 (read) (continued)

# 5.7 Status register 2

Bit	Name	Comment	
15	OUT7 – OC		
14	OUT7 – UC		
13	OUT8 – OC	In case of an over-current event the corresponding status bit OC is set and the output	
12	OUT8 – UC	driver is disabled. If the over-current recovery enable bit is set the output will be	
11	OUT9 – OC	automatically reactivated after a delay time resulting in a PWM modulated current with a programmable duty cycle.	
10	OUT9 – UC	If the over-current recovery bit is not set the micro controller has to clear the over- current bit to reactivate the output driver.	
9	OUT10 – OC	The open load detection monitors the load current in each activated output stage. If the load current is below the under-current detection threshold for at least 1 ms ( $t_{dOL}$ ) the	
8	OUT10 – UC		
7	OUT11 – OC	<ul> <li>corresponding under-current bit UC is set. Due to mechanical/electrical inertia of typical loads a short activation of the outputs (e.g. 3 ms) can be used to test the open</li> </ul>	
6	OUT11 – UC	load status without changing the mechanical/electrical state of the loads.	
5	Reserved		
4	Reserved		
3	VS under-voltage	In case of an over-voltage or under-voltage event the corresponding bit is set and the	
	VS	- outputs are deactivated. If VS voltage recovers to normal operating conditions outputs	
2	over-voltage	are reactivated automatically (if bit 4 of control register 3 is not set).	
1	0	Reserved	
0	0	I Cosciveu	

#### Table 30. Status register 2 (read)



# 5.8 Configuration register

	Table 31. Configuration register (read/write)				
Bit	Name	Comment			
15	0				
14	0				
13	0				
12	0				
11	0	- - Reserved (has to be set to '0') -			
10	0				
9	0				
8	0	-			
7	0				
6	0				
5	Mask for bit 15 of status reg. 1	Open-load event (under-current status bit of OUT1 HS) is not considered in open-load bit 1 of global status register.			
4	Mask for bit 14 of status reg. 1	Open-load event (under-current status bit of OUT1 LS) is not considered in open-load bit 1 of global status register.			
3	Mask for bit 3 of global status reg.	Temperature warning event is not considered in the 'Global Error Flag'.			
2	0	Reserved (has to be set to '0')			
1	Mask for bit 1 of global status reg.	Open-load event (under-current status bit of OUTn) is not considered in the 'Global Error Flag'.			
0	0	Reserved (has to be set to '0')			

#### Table 31. Configuration register (read/write)



# 6 Package and PCB thermal data

### 6.1 PowerSSO-36 thermal data

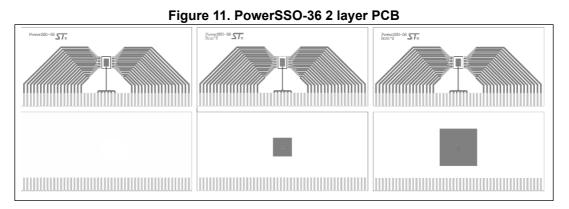
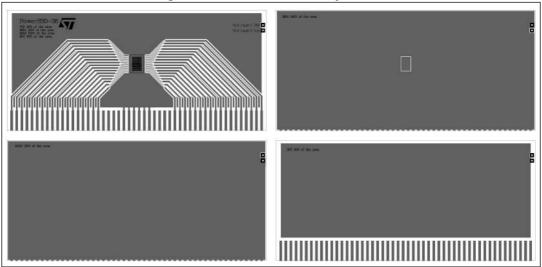


Figure 12. PowerSSO-36 4 layer PCB



Note: Layout condition of  $R_{th}$  and  $Z_{th}$  measurements (board finish thickness 1.6 mm ±10%, board double layer and four layers, board dimension 129 mm x 60 mm, board material FR4, Cu thickness 0.070 mm (outer layers), Cu thickness 0.035 mm (inner layers), thermal vias separation 1.2 mm, thermal via diameter 0.3 mm ±0.08 mm, Cu thickness on vias 0.025 mm, footprint dimension 4.1 mm x 6.5 mm). 4-layer PCB: Cu on mid1 and mid2 layer: 76.45 cm<sup>2</sup>. Cu on bottom layer: 68.8 cm<sup>2</sup>.  $Z_{th}$  measured on the major power dissipator contributor.



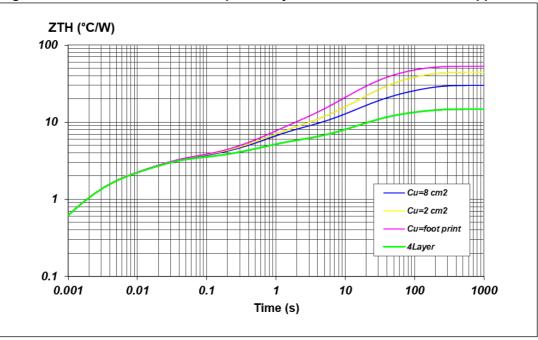


Figure 13. PowerSSO-36 thermal impedance junction to ambient vs PCB copper area



# 7 Package and packing information

### 7.1 ECOPACK

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: *www.st.com*.

ECOPACK is an ST trademark.

# 7.2 PowerSSO-36 package information

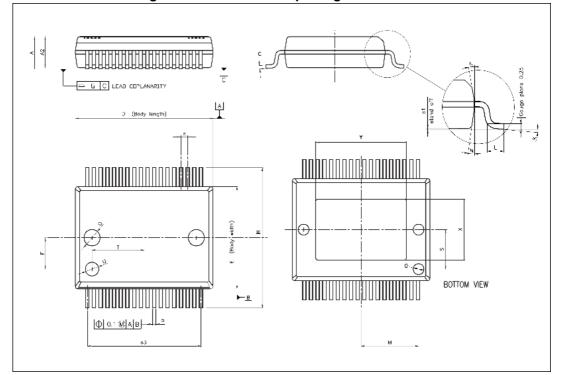


Figure 14. PowerSSO-36 package dimensions

Symbol	Millimeters			
Symbol	Min.	Тур.	Max.	
А	-	-	2.45	
A2	2.15	-	2.35	
a1	0	-	0.1	
b	0.18	-	0.36	
С	0.23	-	0.32	
D <sup>(1)</sup>	10.10	-	10.50	

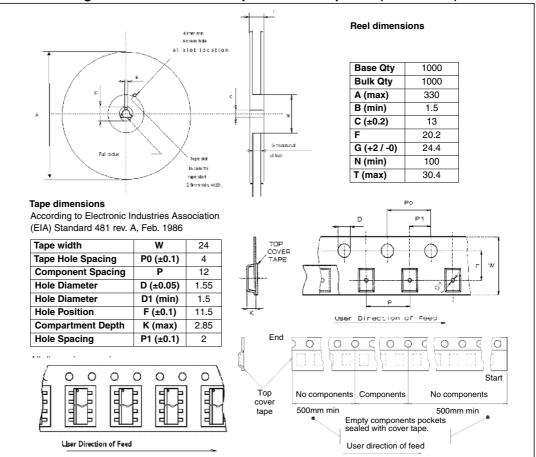
Symbol	Millimeters		
Symbol	Min.	Тур.	Max.
E	7.4	-	7.6
e	-	0.5	-
e3	-	8.5	-
F	-	2.3	-
G	-	-	0.1
G1	-	-	0.06
Н	10.1	-	10.5
h	-	-	0.4
k	0°	-	8°
L	0.55	-	0.85
М	-	4.3	-
N	-	-	10°
0	-	1.2	-
Q	-	0.8	-
S	-	2.9	-
Т	-	3.65	-
U	-	1	-
Х	4.3	-	5.2
Y	6.9	-	7.5

Table 32	PowerSSO-36	mechanical	data	(continued)
	1 0 10 0 0 0 - 0 0	mechanica	uala	(Continueu)

1. "D" and "E" do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.15 mm per side (0.006").



## 7.3 PowerSSO-36 packing information



#### Figure 15. PowerSSO-36 tape and reel shipment (suffix "TR")



# 8 Revision history

Table 33.	Document	revision	history
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Date	Revision	Description of changes
18-Sep-2018	1	Initial release.
07-Nov-2018	2	Added Section 6: Package and PCB thermal data.
17-Jun-2019	3	Updated the maturity from target specification to production data.
08-Oct-2019	4	Updated <i>Applications</i> on cover page. Updated <i>Table 2: Pin definition and functions</i> . Updated <i>Section 4.1.1: Chip Select Not (CSN)</i> and <i>Section 4.3: Global status byte</i> . Minor text changes



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